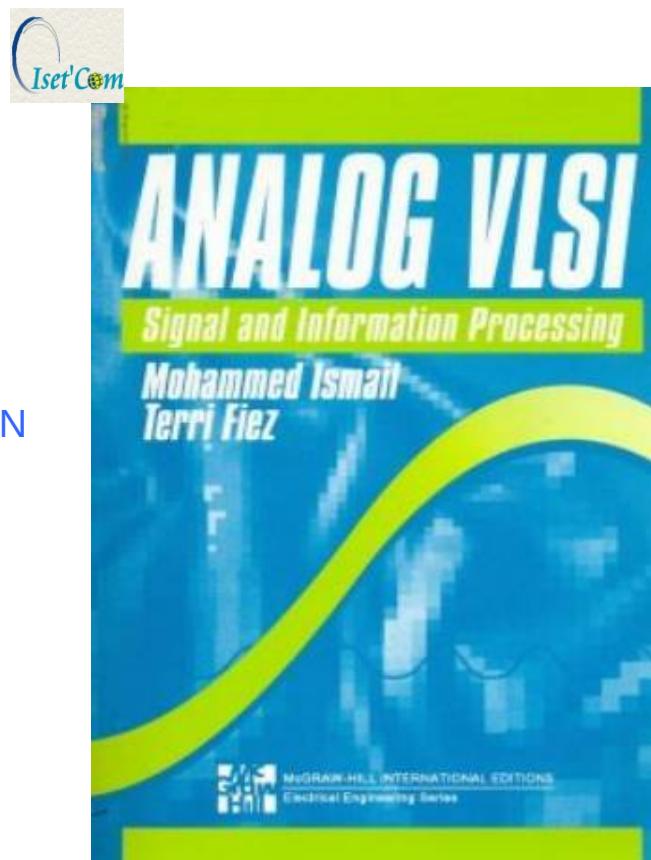


**ANALOG VLSI  
SIGNAL  
AND INFORMATION  
PROCESSING**

**MOHAMMD ISMAIL  
ET  
TERRI FEIZ**



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